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Substitute for form 1449A/B/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use as many sheets as necessary)

Sheet	1	of	2	Attorney Docket Number	384848010US
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Complete If Known

Application Number	10/796,270-Conf. #2382
Filing Date	March 9, 2004
First Named Inventor	Jack Z. Peng
Art Unit	2824
Examiner Name	H. N. Nguyen

U.S. PATENT DOCUMENTS

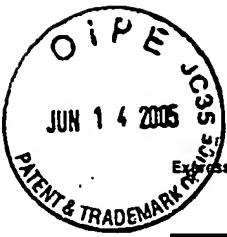
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner Signature	HEN NGUYEN	Date Considered	12/01/05
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				Application Number	10/796,270-Conf. #2382
				Filing Date	March 9, 2004
				First Named Inventor	Jack Z. Peng
				Art Unit	2824
				Examiner Name	H. N. Nguyen
Sheet	2	of	2	Attorney Docket Number	384848010US

NON PATENT LITERATURE DOCUMENTS						
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				²

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¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT Form PTO-1449 (Modified) (Use several sheets if necessary)				COMPLETE IF KNOWN	
Sheet	1	of	4	Application Number	10/796,210
				Confirmation Number	
				Filing Date	
				First Named Inventor	Jianquo Wang
				Group Art Unit	2824
				Examiner Name	H. NGUYEN
				Attorney Docket No.	384848010US

U.S. PATENT DOCUMENTS						
Examiner Initials	Cite No.	U.S. Patent or Application		Name of Patentee or Inventor of Cited Document	Date of Publication or Filing Date of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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COMPLETE IF KNOWN

Application Number	10/796,270
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First Named Inventor	Jianguo Wang
Group Art Unit	2824
Examiner Name	H. NGUYEN

Sheet 2 of 4 Attorney Docket No. 384848010US

U.S. PATENT DOCUMENTS

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Application Number	10/716,270
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First Named Inventor	Jianguo Wang
Group Art Unit	2824
Examiner Name	H. Nguyen

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		Office	NUMBER	Kind Code (if known)				
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Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume issue number(s), publisher, city and/or country where published.	T
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Sheet	4	of	4	Attorney Docket No.	384848010US
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